SHEET	1	OF	1
-------	---	----	---

· ./c	\sqrt{P}	E `							
Form PTD 1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			ATTY DOCKET NO.	SERIAL NO.					
(Modified) PATENT AND TRADEMARK OFFICE			202776US2	09/778,812					
\ \s	Sp 32			APPLICANT					
risk bi	REFE	RENCÉS CITED BY AI	PLICANT	Hiroshi UEDA, et al.					
LIST OF REFERENCES CITED BY APPLICANT			FILING DATE	GROUP					
				February 8, 2001	2871				
				U.S. PATENT DOCUMENTS					
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS SUB FILING DATE CLASS IF APPROPRIATE				
	AA								
	AB								
	AC								
	AD				1				
	AE								
	AF			1	1				
	AG								
ļ	AH								
ļ	Al				†	·			
}	AJ								
	AK								
	AL		 						
	AM								
	AN				<u> </u>				
FOREIGN PATENT DOCUMENTS									
,		DOCUMENT NUMBER	DATE	COUNTRY		TRANSLATION			
-	AO	10-260421	9/29/1998	Janes (w/ English Abstract)		YES			
 	AP	4-28289	1/30/1992	Japan (w/ English Abstract) Japan (w/ English Abstract)			X		
1-11-	AQ	4-287022	10/12/1992	Japan (w/ English Abstract)			×		
 	AR	4-289824	10/14/1992	Japan (w/ English Abstract)			×		
\vdash	AS	4-209024	10/14/1992	Japan (w/ English Abstract)			×		
	AT					-			
-	AU								
ļ	AV								
	~~						1		
<u> </u>	,	OTHER RI	FERENCES (Including Author, Title, Date, Pertinen	t Pages, e	lc.)			
	AW								
	AX								
	AY					-			
	AZ				Additional References/sheet(s) attached				
Examiner		Date Considered 8/11/1							
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.									

BEST AVAILABLE COPY

